

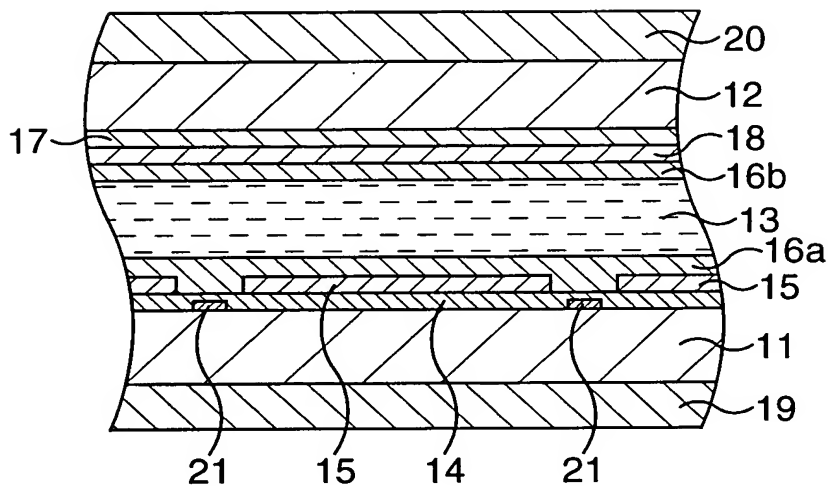
[illegible]

FIG. 2A

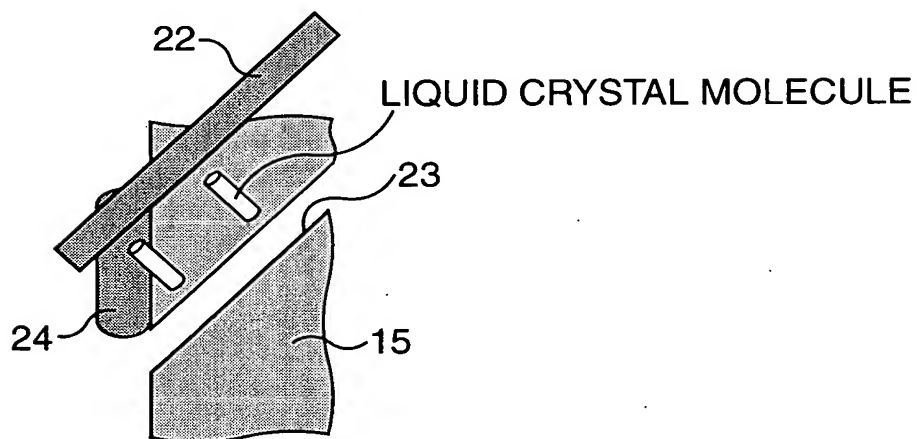


FIG. 2B

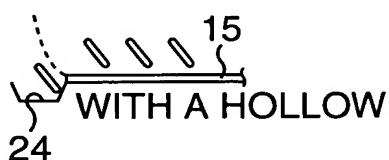
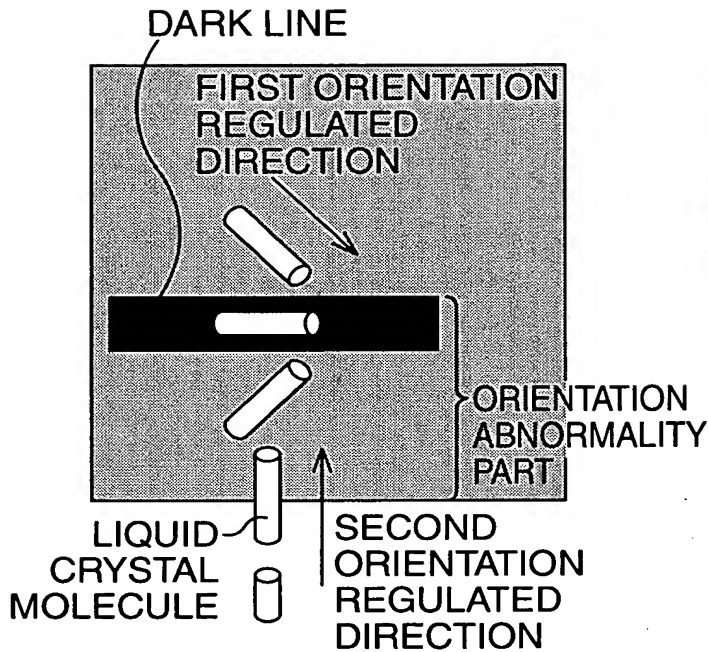


FIG. 2C

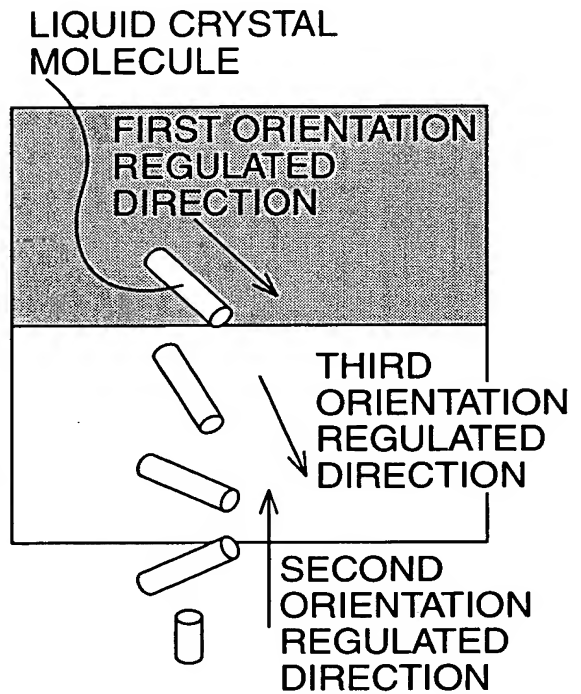


FIG. 3A



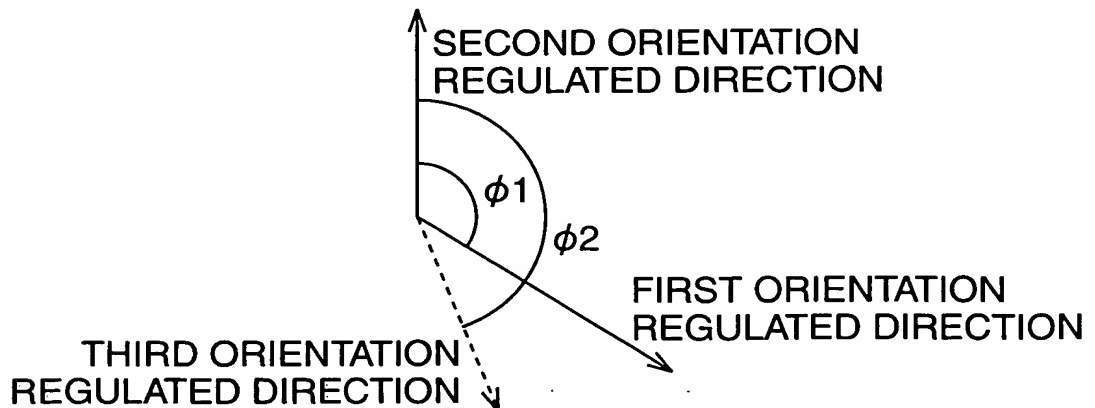
CONVENTIONAL

FIG. 3B



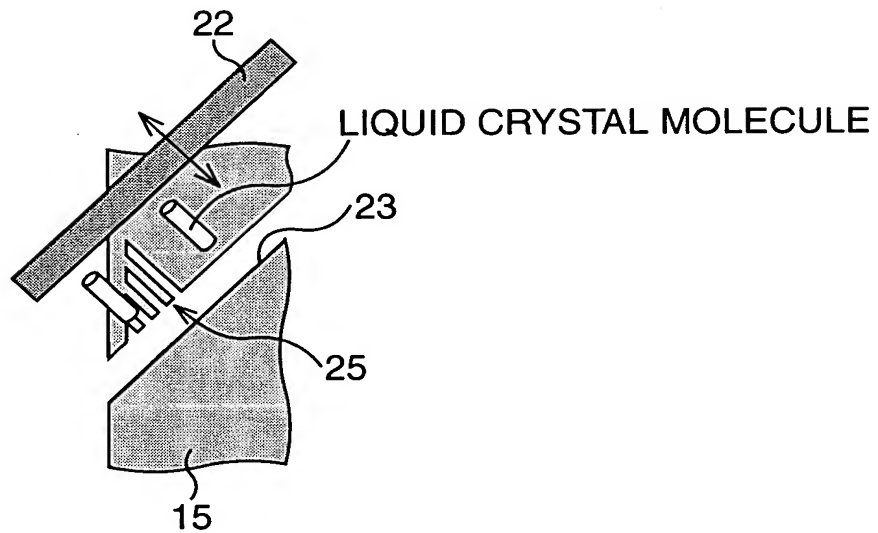
GIVE A THIRD REGULATING FORCE

FIG. 3C



RELATION BETWEEN DIRECTIONS OF  
 ALIGNING FORCE AND ANGLES

FIG. 4



4004725-01400

FIG. 5

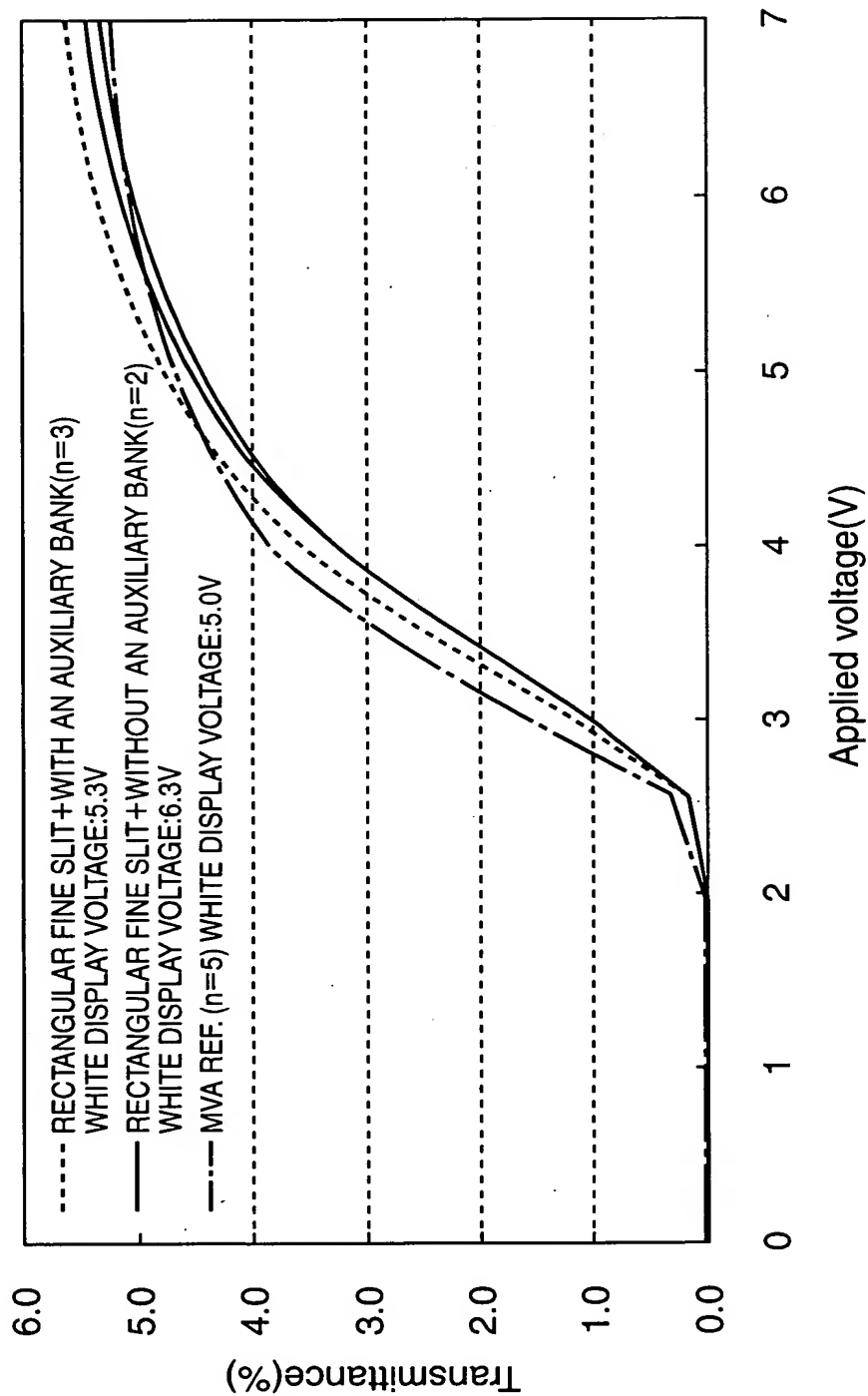
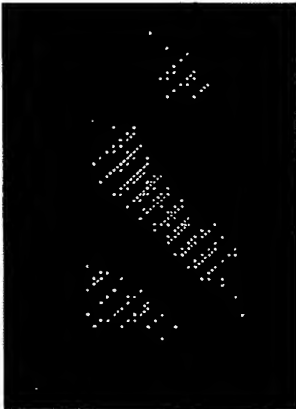
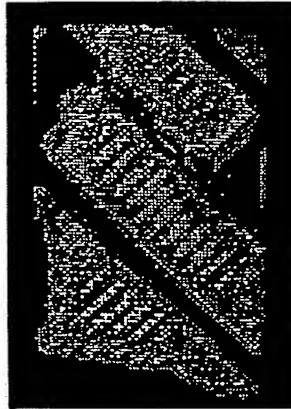


FIG. 6A



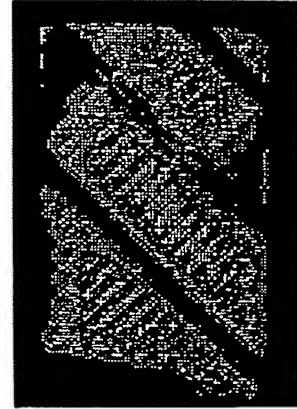
APPLIED  
VOLTAGE : 3V

FIG. 6B



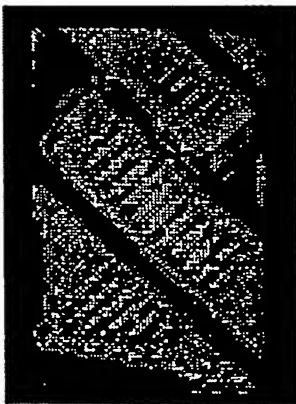
APPLIED  
VOLTAGE : 4V

FIG. 6C



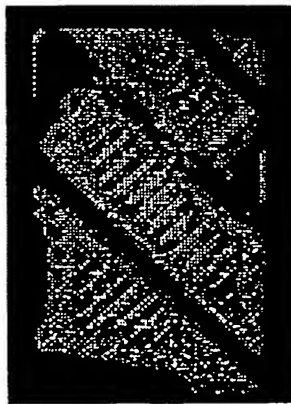
APPLIED  
VOLTAGE : 5V

FIG. 6D



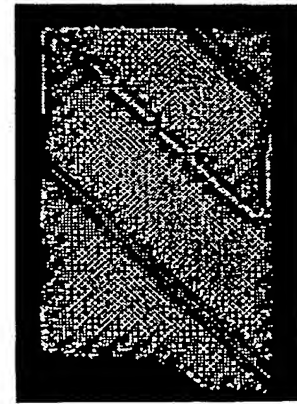
APPLIED  
VOLTAGE : 6V

FIG. 6E



APPLIED  
VOLTAGE : 7V

FIG. 6F

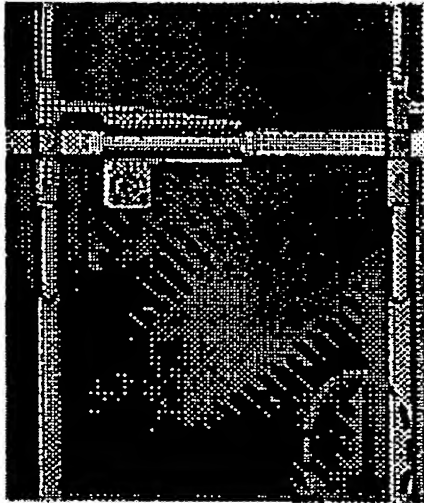


APPLIED  
VOLTAGE : 8V

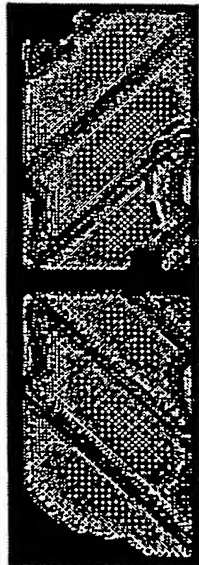
2011-10-31 10:34:00

FIG. 7

FINE SLIT(SHALLOW CUT)

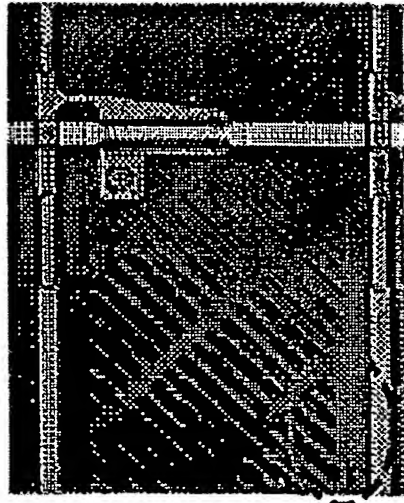


PIXEL ELECTRODE  
PATTERN

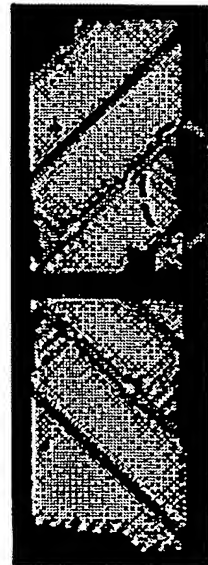


ORIENTATION STATE

FINE SLIT(DEEP CUT)



PIXEL ELECTRODE  
PATTERN



ORIENTATION STATE

104245 0404

FIG. 8

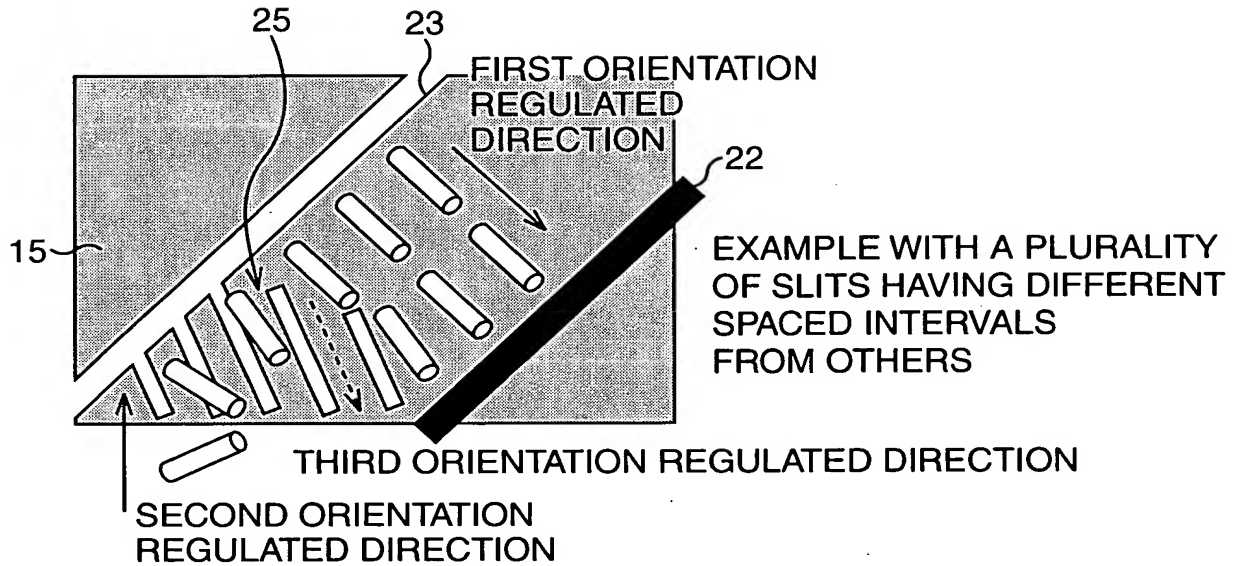


FIG. 9

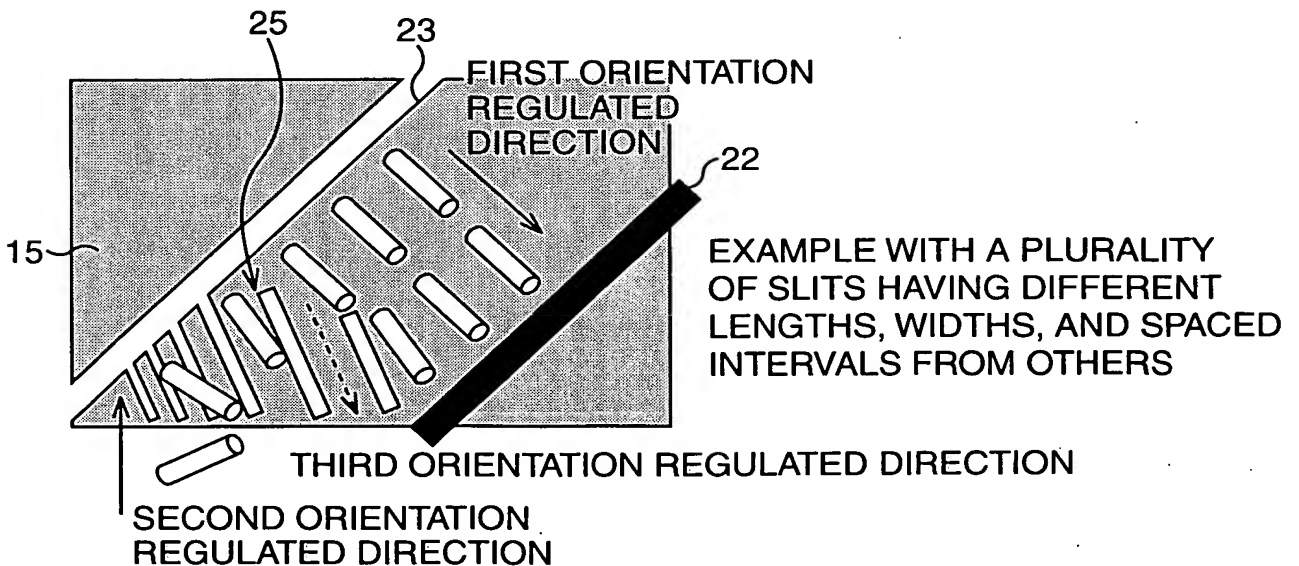


FIG. 10

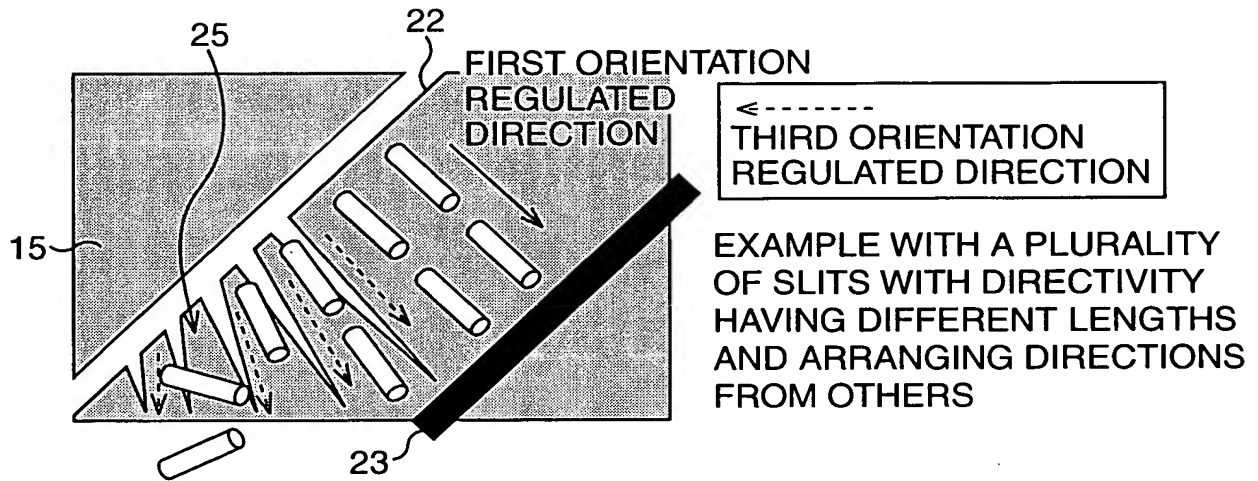




FIG. 11

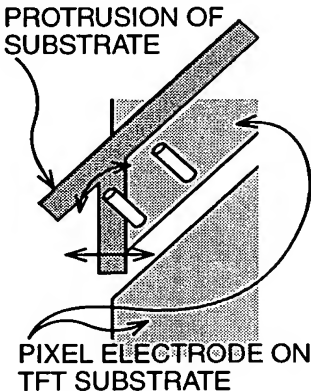
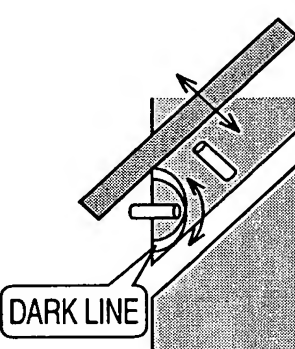
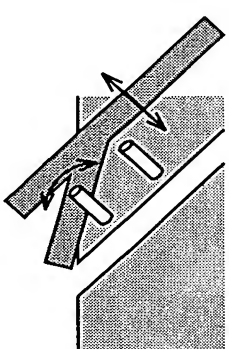
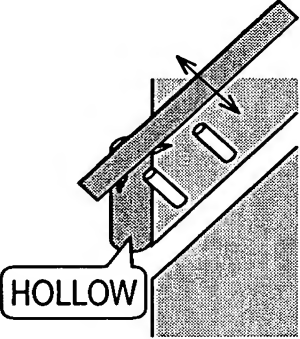
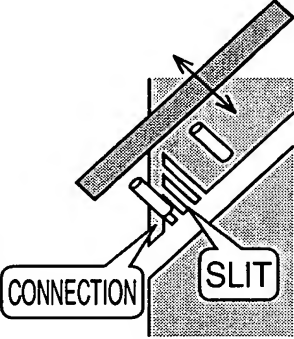
	①WITH AN AUXILIARY BANK	②WITHOUT AN AUXILIARY BANK	③CHANGE THE DIRECTION OF AN AUXILIARY BANK
STRUCTURE	 <p>PROTRUSION OF SUBSTRATE</p> <p>PIXEL ELECTRODE ON TFT SUBSTRATE</p>	 <p>DARK LINE</p>	
TRANSMITTANCE	1	0.9	0.95
MISALIGNMENT MARGIN	x	o	Δ
FEATURES	<ul style="list-style-type: none"> <li>• LIQUID CRYSTAL ORIENTATION OF A PIXEL EDGE CHANGES GREATLY DUE TO DEVIATION AMONG EACH SHOT AND IN PASTING (A LARGE DEGREE OF TRANSMITTANCE CHANGE)</li> <li>• NO DARK LINE ON A PIXEL EDGE (A LARGE DEGREE OF IMPROVEMENT IN TRANSMITTANCE)</li> </ul>	<ul style="list-style-type: none"> <li>• LIQUID CRYSTAL ORIENTATION OF A PIXEL EDGE CHANGES DUE TO DEVIATION AMONG EACH SHOT AND IN PASTING (TO A SMALL DEGREE)</li> <li>• OCCURRENCE OF ONE DARK LINE ON A PIXEL EDGE (A LARGE DEGREE OF DECREASE IN TRANSMITTANCE)</li> </ul>	<ul style="list-style-type: none"> <li>• LIQUID CRYSTAL ORIENTATION OF A PIXEL EDGE CHANGES DUE TO DEVIATION AMONG EACH SHOT AND IN PASTING</li> <li>• NO DARK LINE ON A PIXEL EDGE</li> </ul>

FIG. 12

	④HOLLOW IN A PIXEL EDGE	⑤FINE SLITS +CONNECTION AT THE END
STRUCTURE		
TRANSMITTANCE	0.92	0.95
MISALIGNMENT MARGIN	○	◎
FEATURES	<ul style="list-style-type: none"> <li>· LIQUID CRYSTAL ORIENTATION OF A PIXEL EDGE CHANGES DUE TO DEVIATION AMONG EACH SHOT AND IN PASTING (WITH A MARGIN)</li> <li>· NO DARK LINE ON A PIXEL EDGE</li> </ul>	<ul style="list-style-type: none"> <li>· LIQUID CRYSTAL ORIENTATION DOES NOT CHANGE EASILY DUE TO DEVIATION AMONG EACH SHOT AND IN PASTING (WITH THE LARGEST MARGIN)</li> <li>· NO DARK LINE AT A PIXEL EDGE (TRANSMITTANCE UNDER IMPROVEMENT)</li> <li>· TRANSMITTANCE IS IMPROVED GREATLY AT A DRIVING VOLTAGE OF 6V OR HIGHER (EQUAL TO ①)</li> </ul>

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FIG. 13

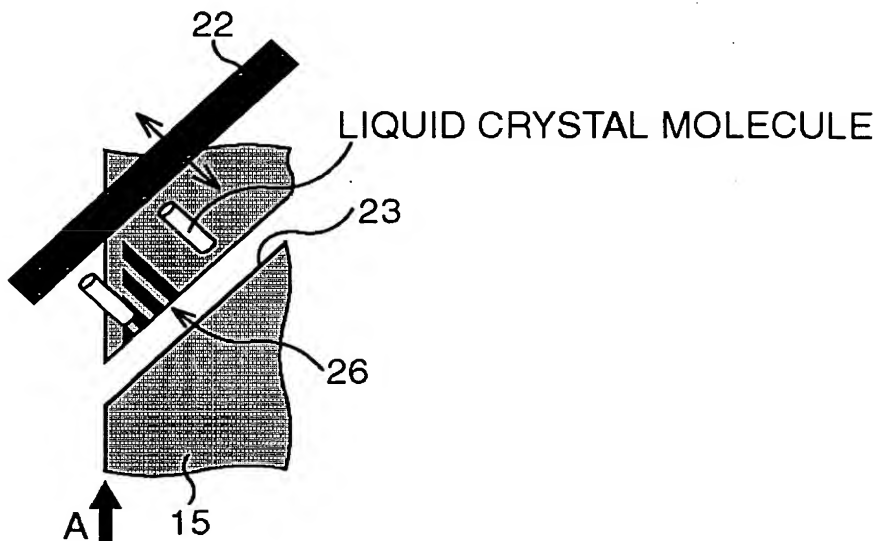


FIG. 14A

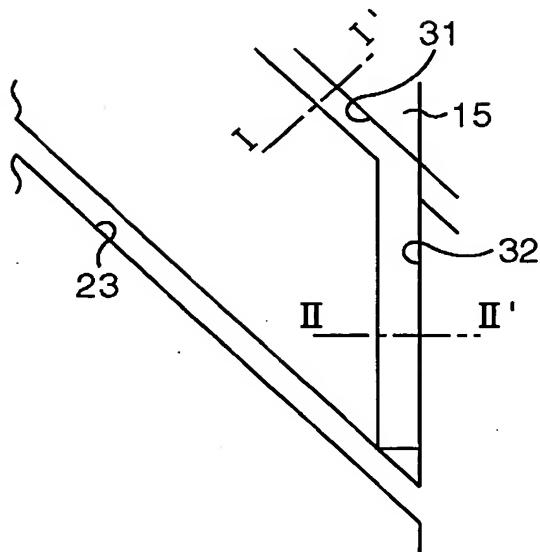


FIG. 14B

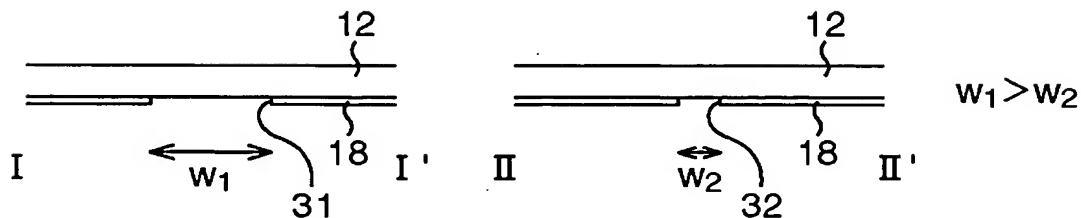


FIG. 15A

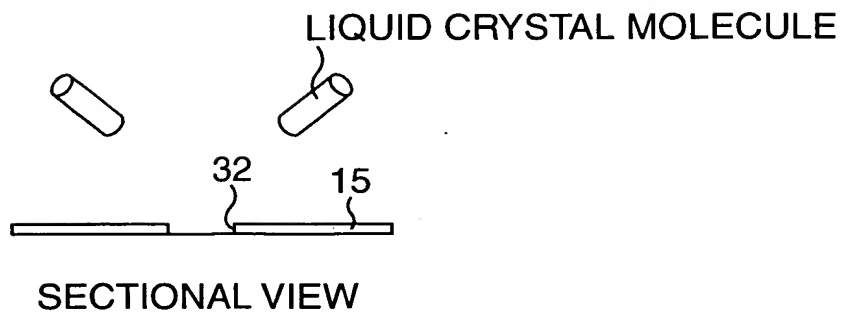


FIG. 15B

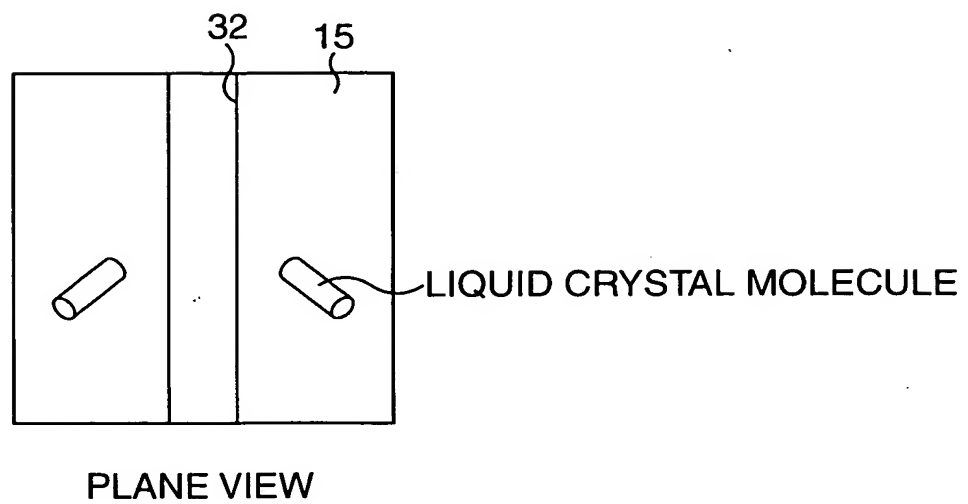


FIG. 16A

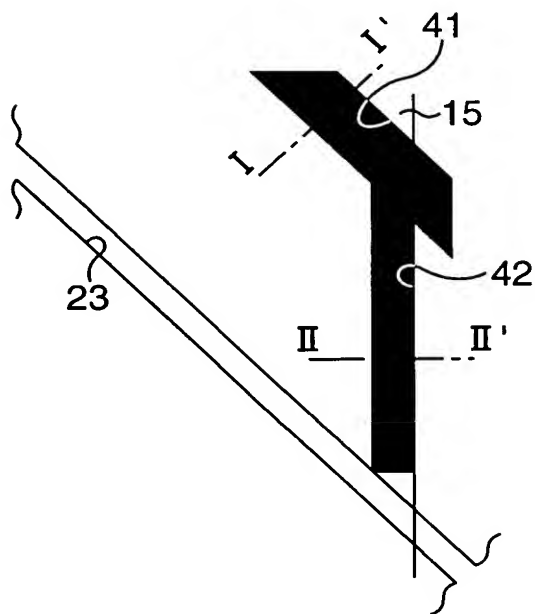


FIG. 16B

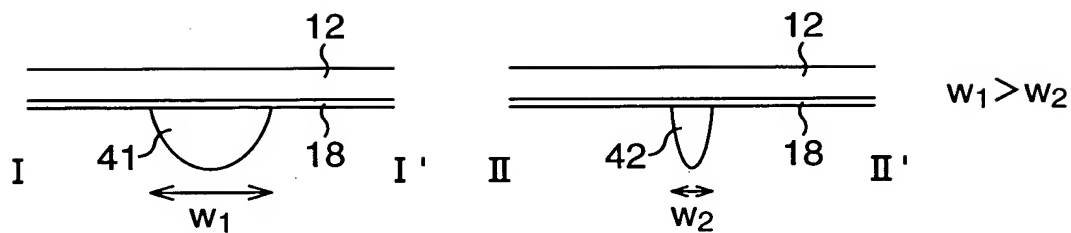


FIG. 17A

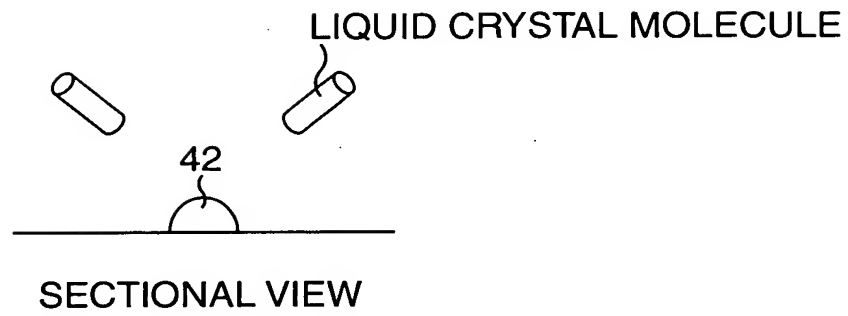


FIG. 17B

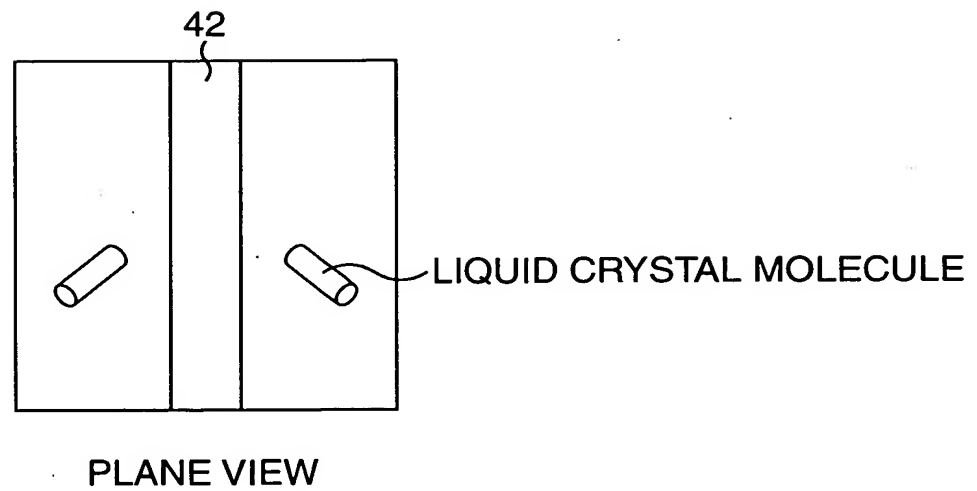
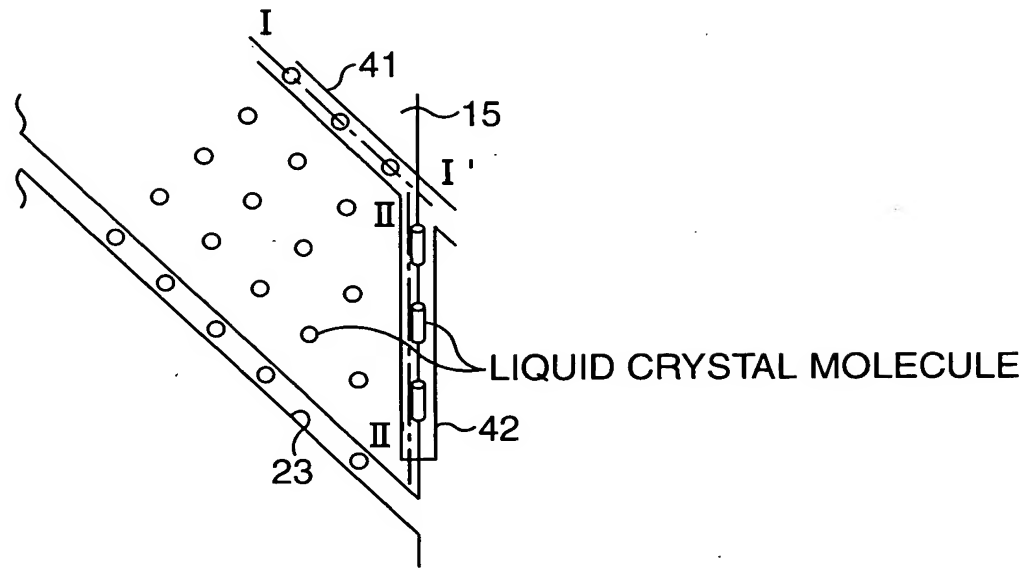
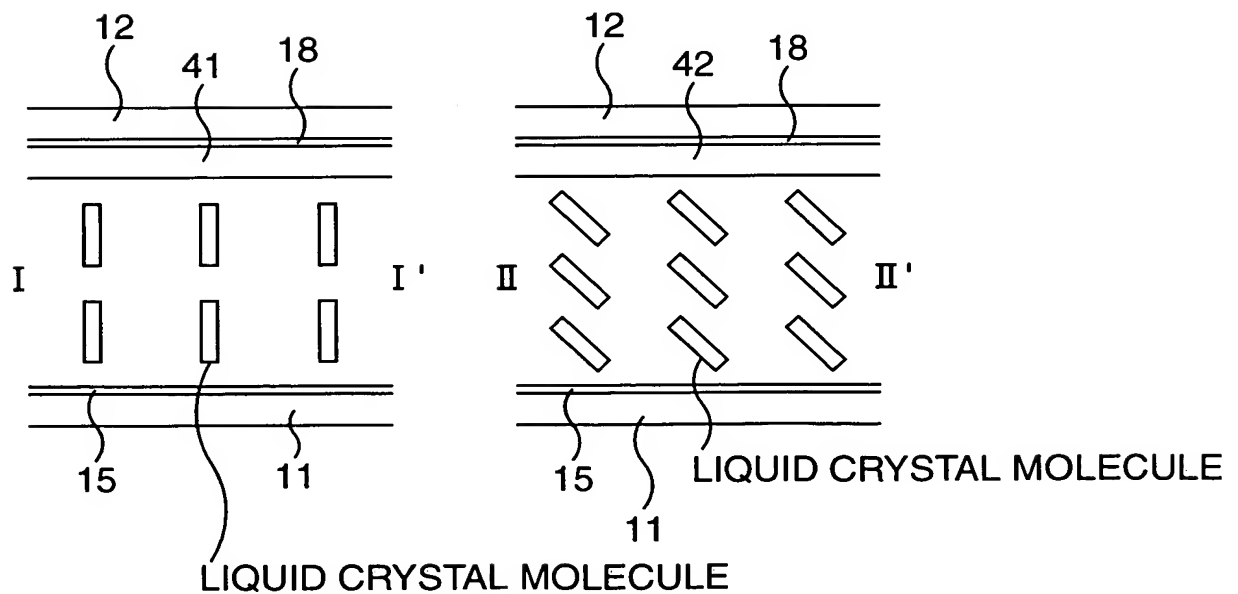


FIG. 18A



PLANE VIEW

FIG. 18B



SECTIONAL VIEW

FIG. 19A

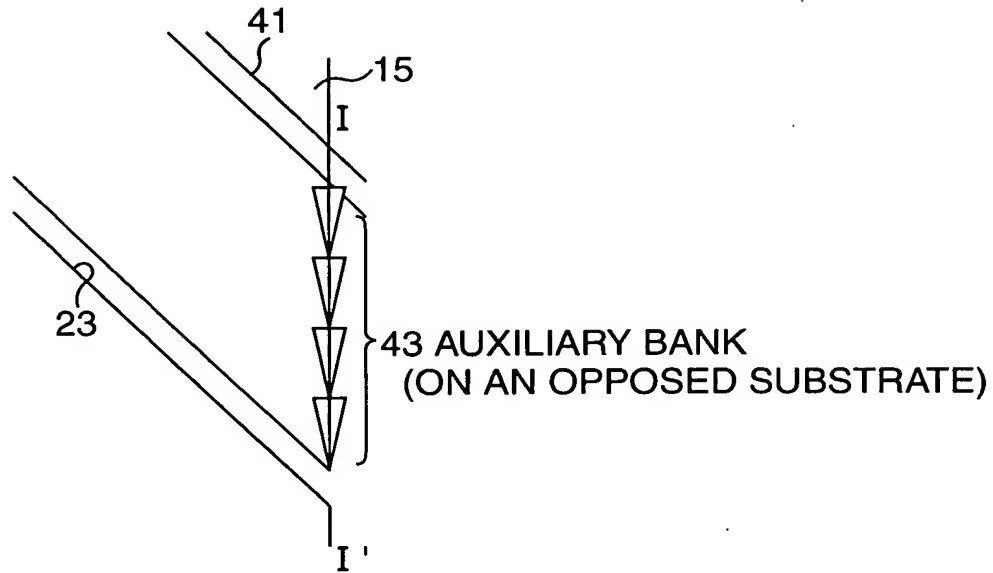
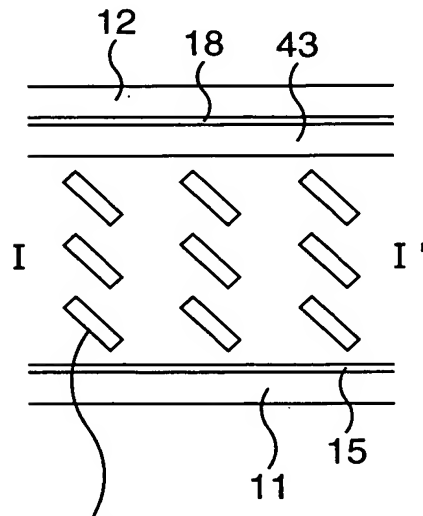


FIG. 19B



LIQUID CRYSTAL MOLECULE

SECTIONAL VIEW

2014105124001



FIG. 20A

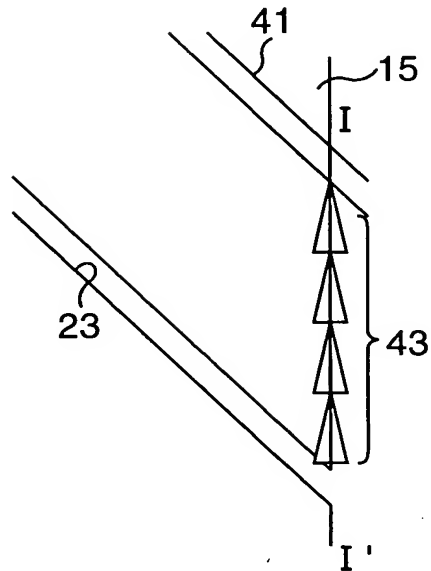
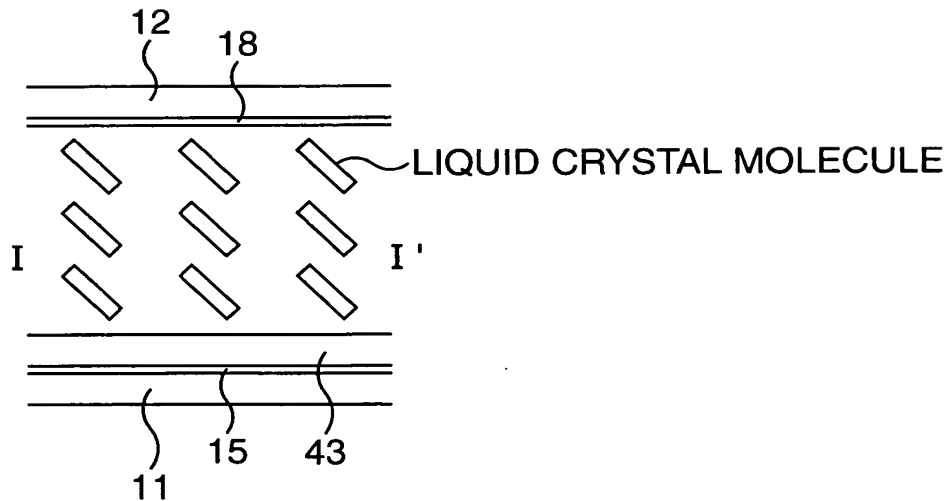


FIG. 20B



SECTIONAL VIEW

FIG. 21A

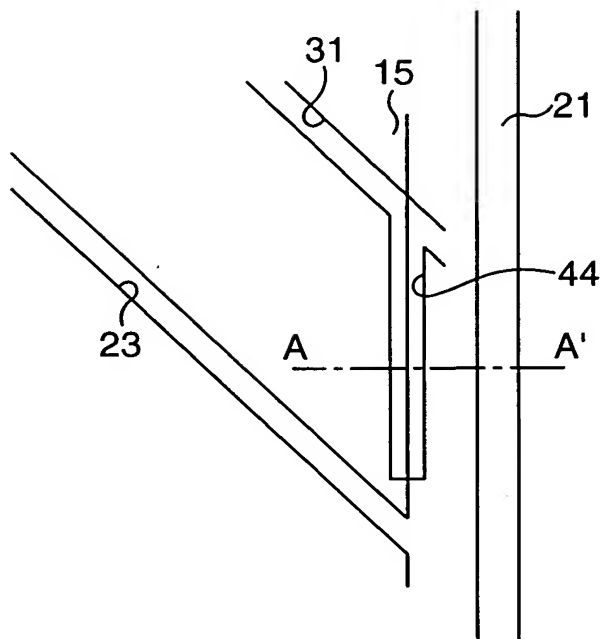


FIG. 21B

A REGION WITH NO ELECTRODE ON BOTH OF THE SUBSTRATES

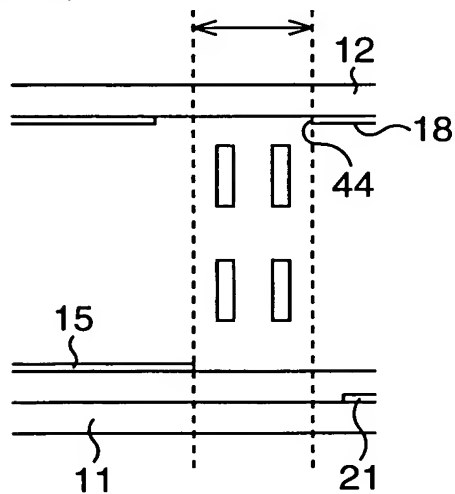
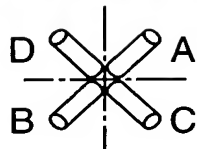
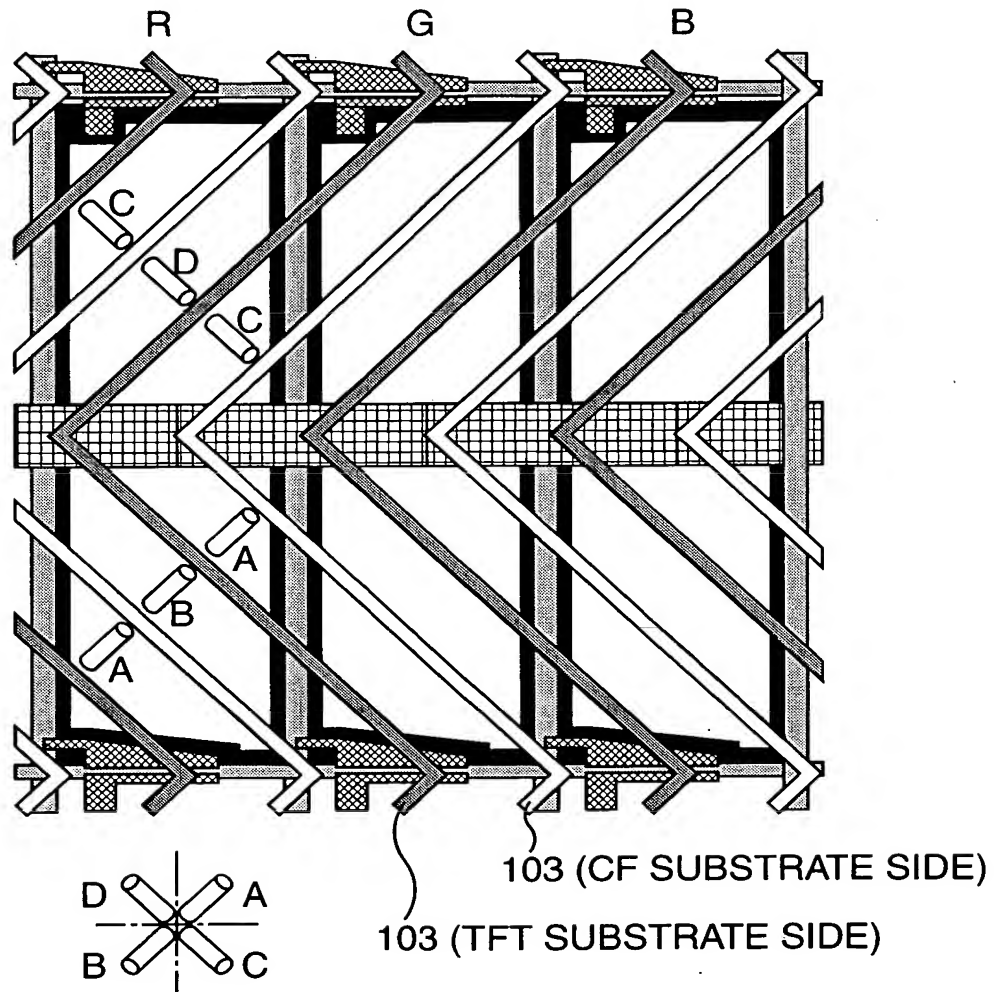


FIG. 22



ALIGNMENT DIRECTION OF  
 THE LIQUID CRYSTAL MOLECULE

PIXEL STRUCTURE OF AN MVA LIQUID CRYSTAL DISPLAY (ONE PIXEL)

FIG. 23A

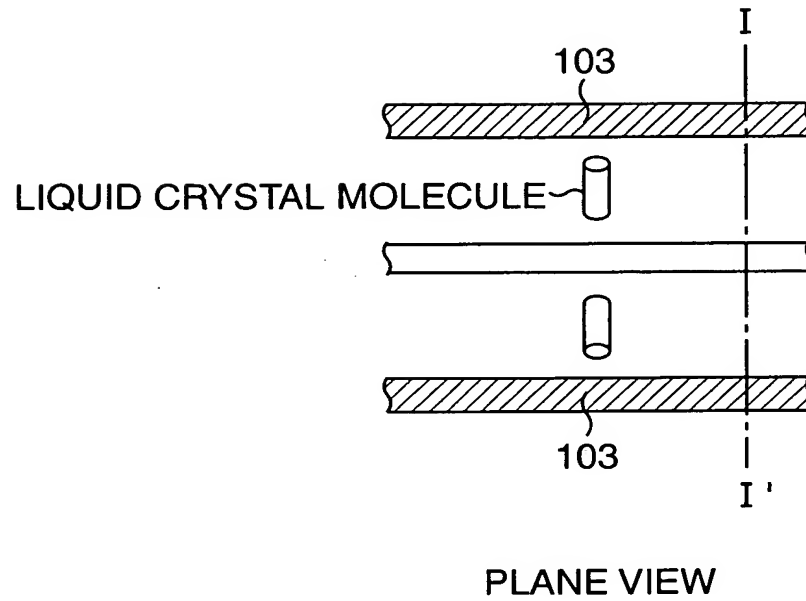


FIG. 23B

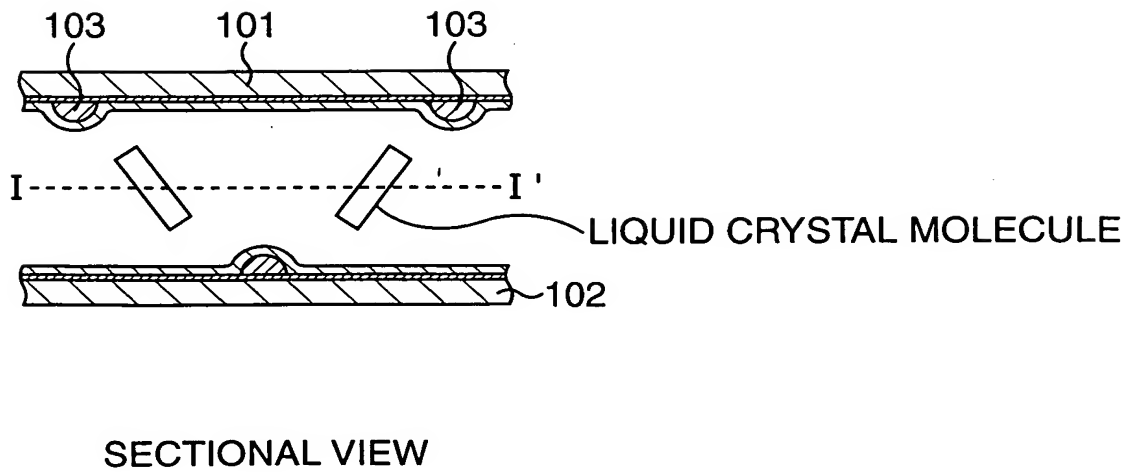


FIG. 24A

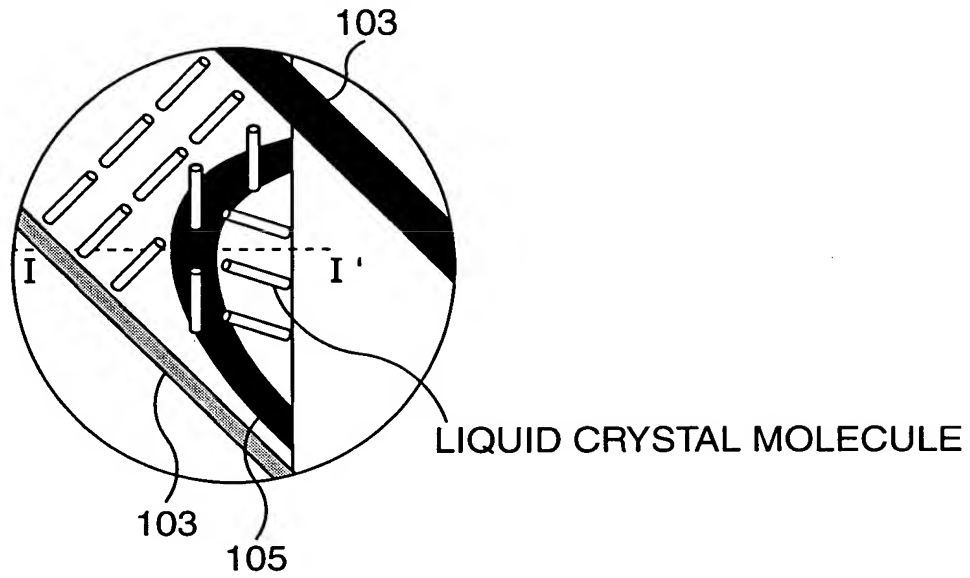


FIG. 24B

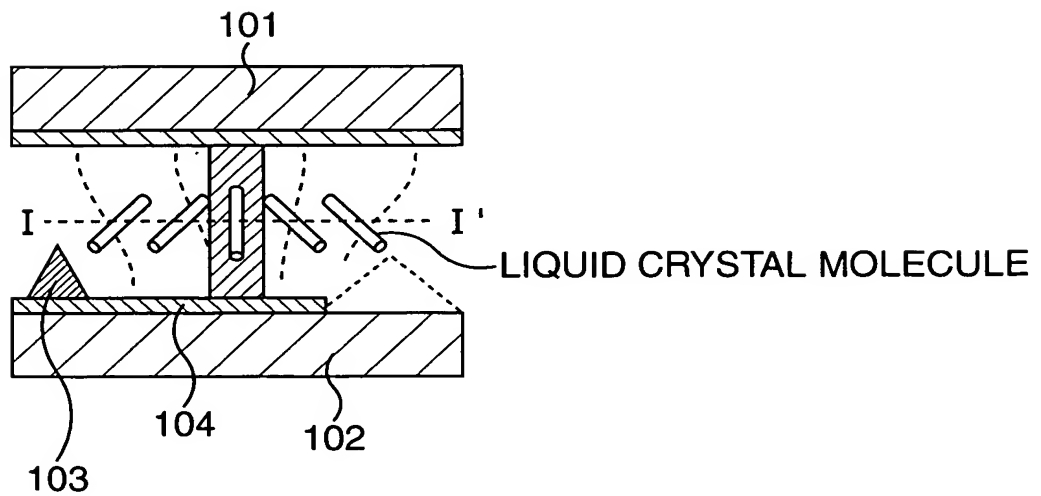
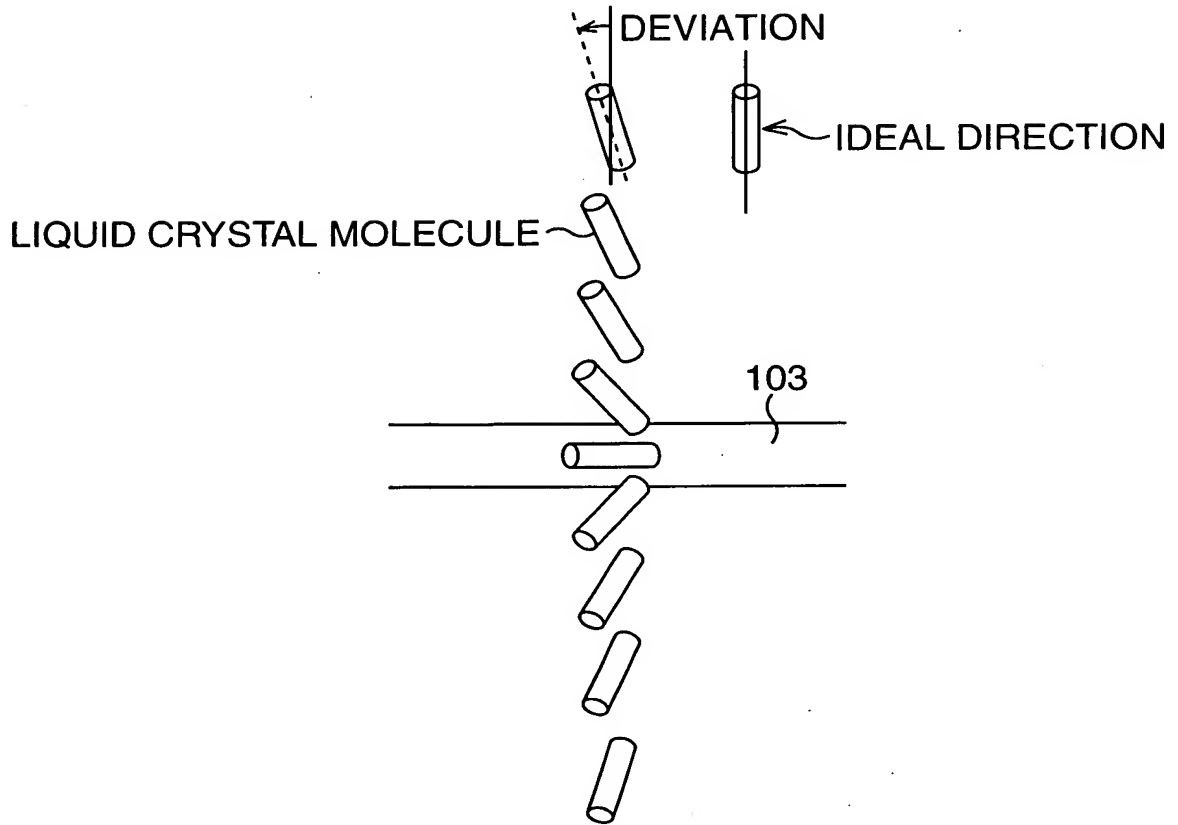
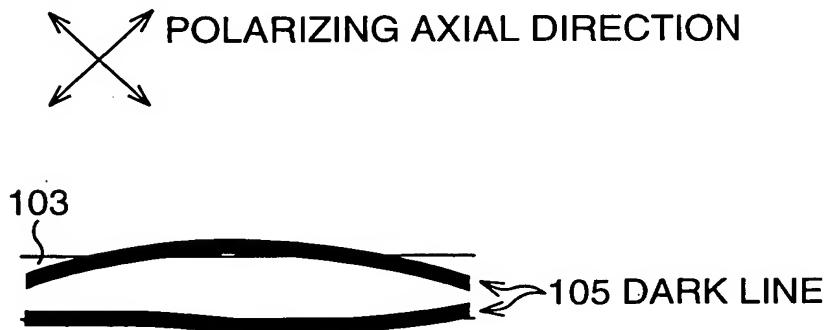


FIG. 25A



ALIGNMENT DIRECTION OF THE LIQUID CRYSTAL MOLECULE

FIG. 25B



OPTICAL APPEARANCE

FIG. 26A

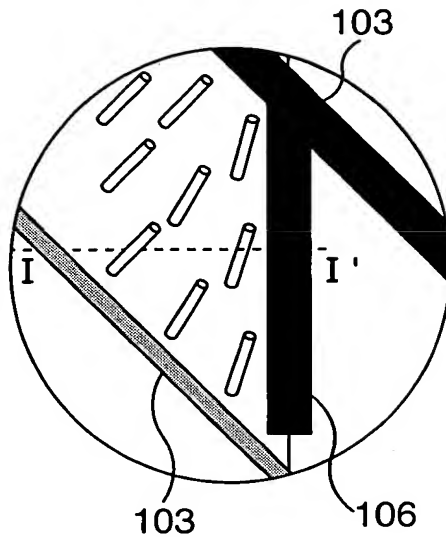


FIG. 26B

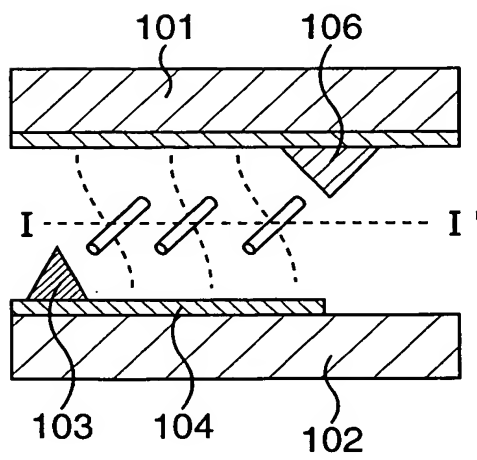


FIG. 27A

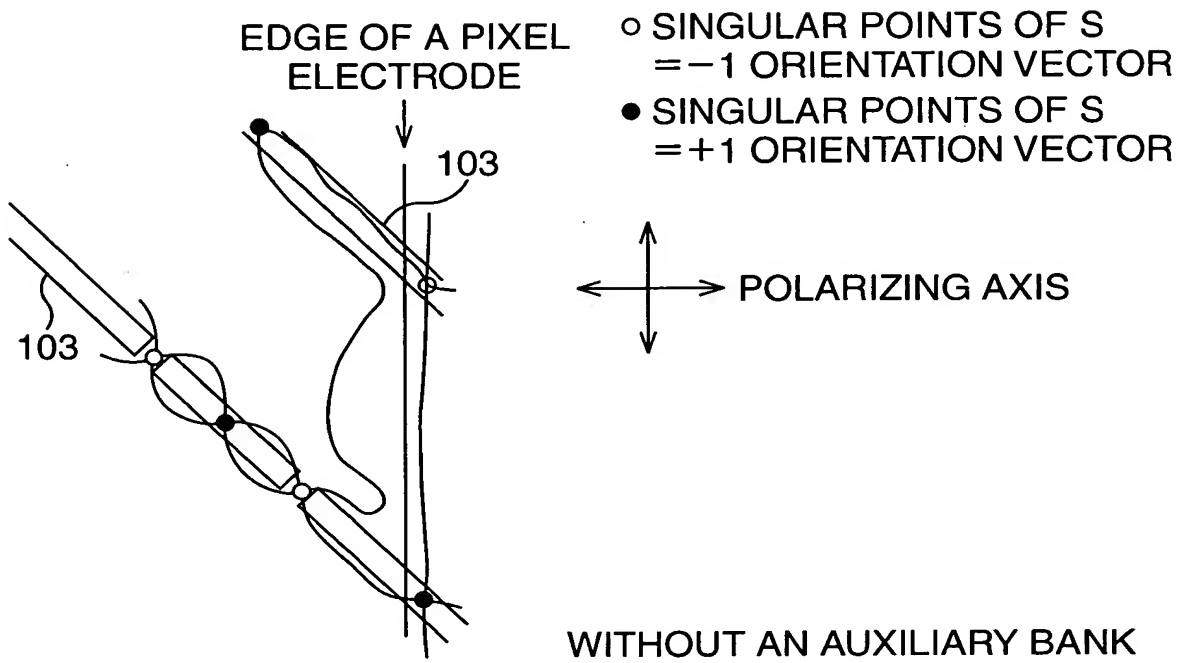


FIG. 27B

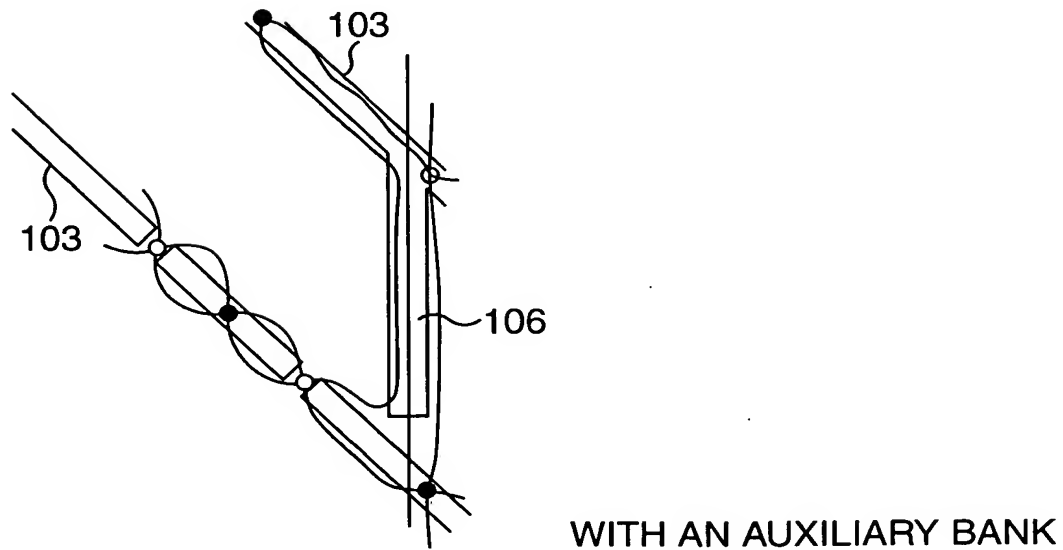




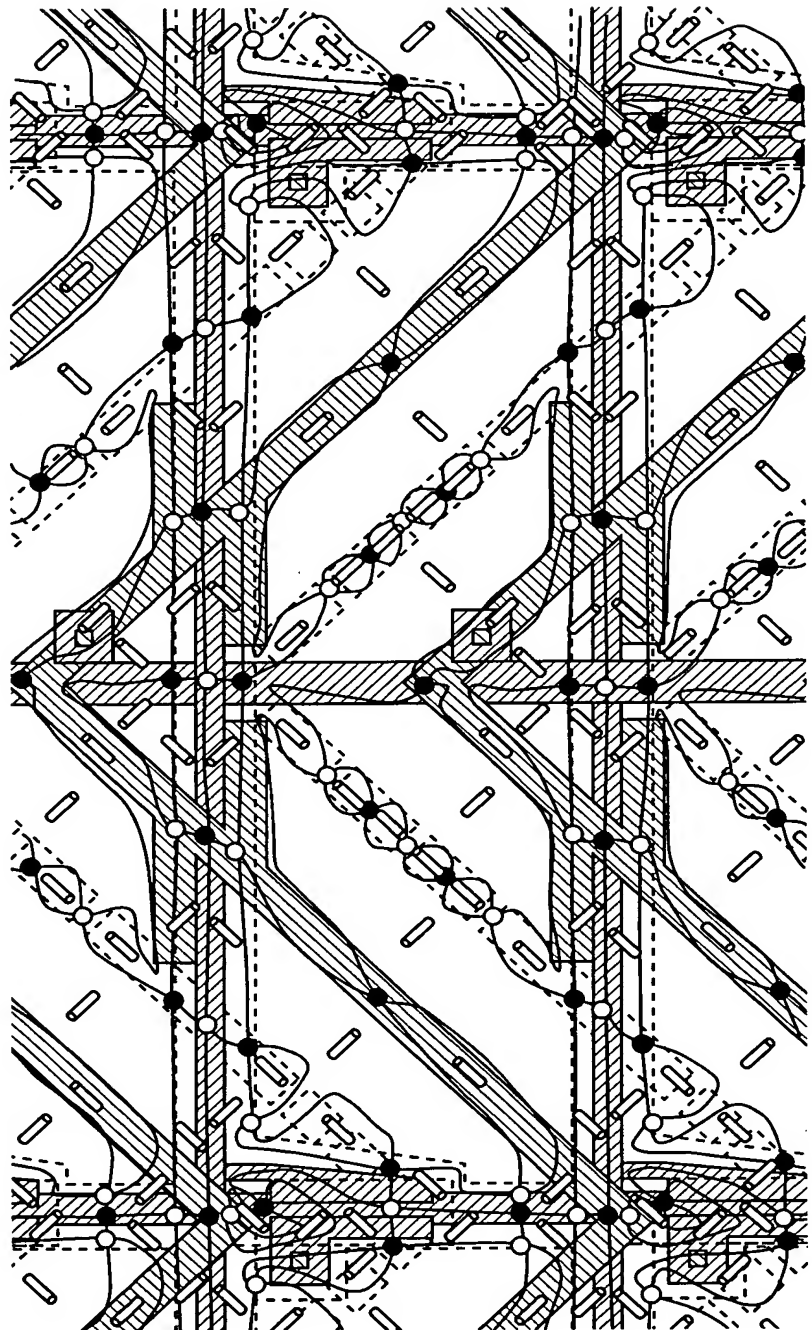
FIG. 28

STRENGTH OF  
 SINGULAR POINTS OF  
 ORIENTATION VECTOR

● S=+1

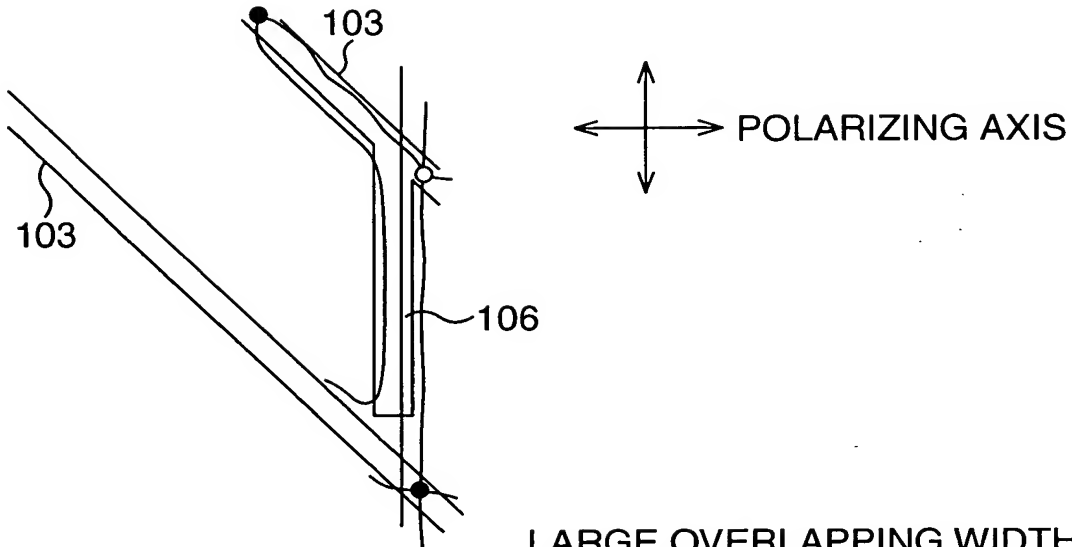
○ S=-1

OBSERVED WITH A TFT  
 SUBSTRATE ON  
 A LOWER SIDE AND  
 A CF SUBSTRATE ON  
 AN UPPER SIDE



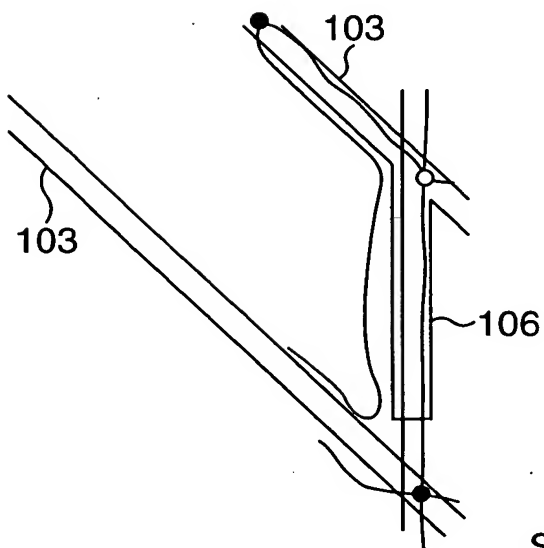
20110522001

FIG. 29A



LARGE OVERLAPPING WIDTH OF  
AN AUXILIARY PROTRUSION AND  
A PIXEL EDGE

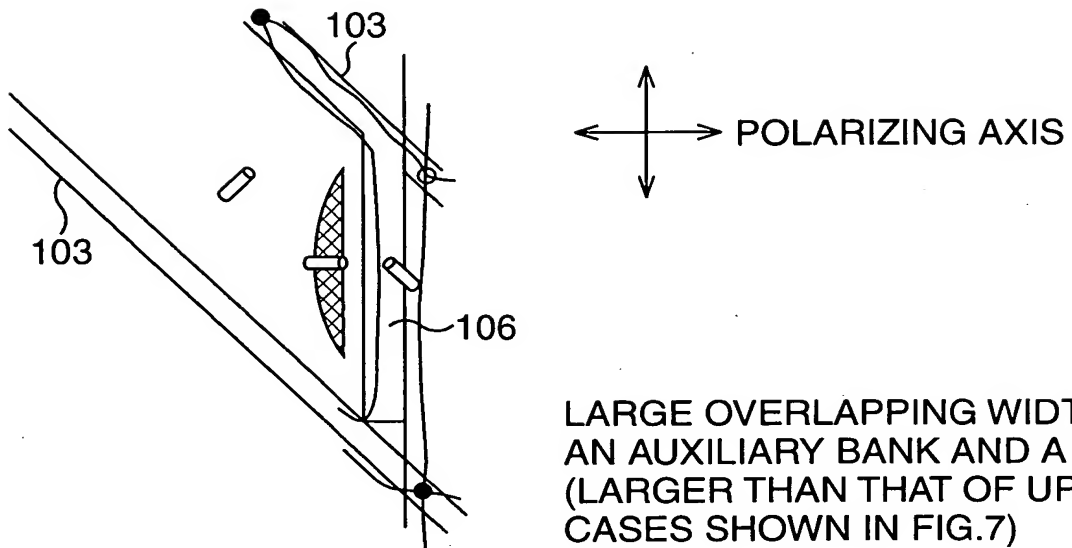
FIG. 29B



SMALL OVERLAPPING WIDTH OF  
AN AUXILIARY PROTRUSION AND  
A PIXEL EDGE

FIG. 29A

FIG. 30



LARGE OVERLAPPING WIDTH OF  
AN AUXILIARY BANK AND A PIXEL  
(LARGER THAN THAT OF UPPER  
CASES SHOWN IN FIG. 7)